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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/539,758 | | Applicant(s)/Patent Under Reexamination ANTONISSEN ET AL. | |
| | Examiner CHRISTINE CHEN | | Art Unit 1793 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,589,369 | 07-2003 | Yokoi et al. | 148/320 |
| * | B | US-6,632,296 | 10-2003 | Yoshinaga et al. | 148/320 |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------------------|----------------|
| | N | JP10-280087 | 10-1998 | Japan | Itami et al. | |
| * | O | WO01/81640 | 11-2001 | PCT | Yokoi et al. | |
| * | P | WO01/94655 | 12-2001 | PCT | Yoshinaga et al. | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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